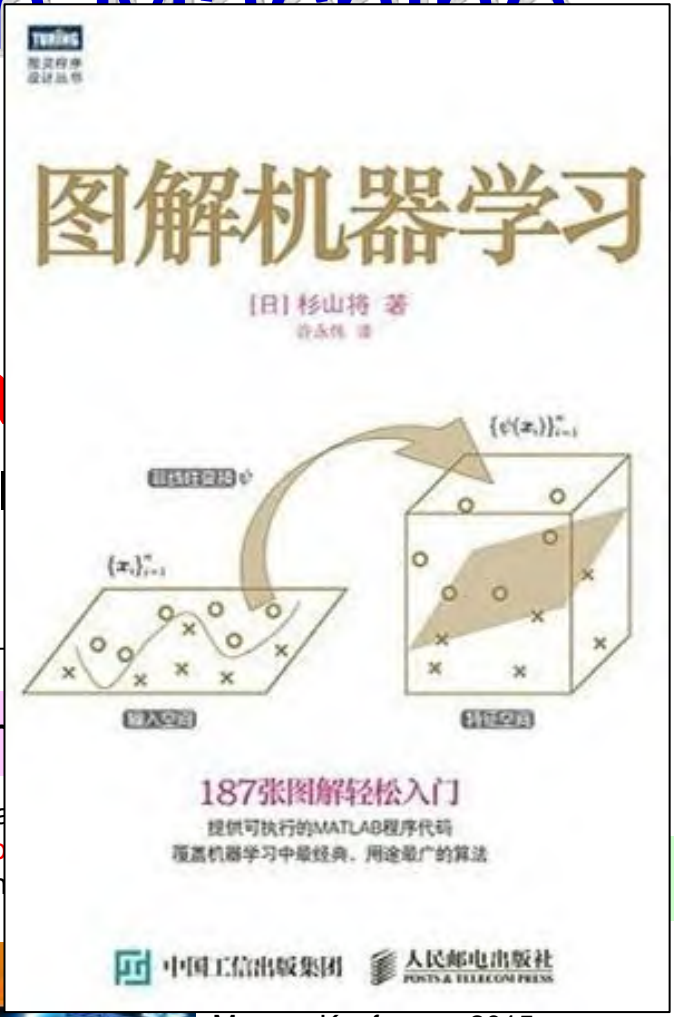
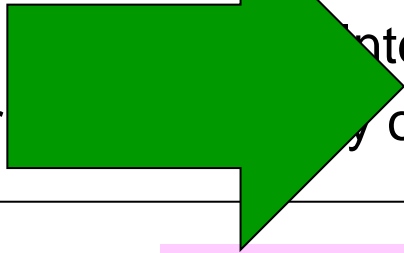


Recent Advances in Machine Learning from Weak



Masashi Sugiyama



Reinforcement

Supervised Learning



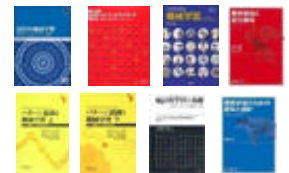
Sugiyama, Suzuki & Kanamori, *Statistical Reinforcement Learning*, Cambridge University Press, 2012

Quinoneiro Sugiyama, Schwaighofer & Lawrence, *Dataset Shift in Machine Learning*, MIT Press, 2009.



Sugiyama, Suzuki & Kanamori, *Density Ratio Estimation in Machine Learning*, Cambridge University Press, 2012

Morgan Kaufmann, 2015



In Japanese, (Chinese & Korean)

What Is My Talk about?

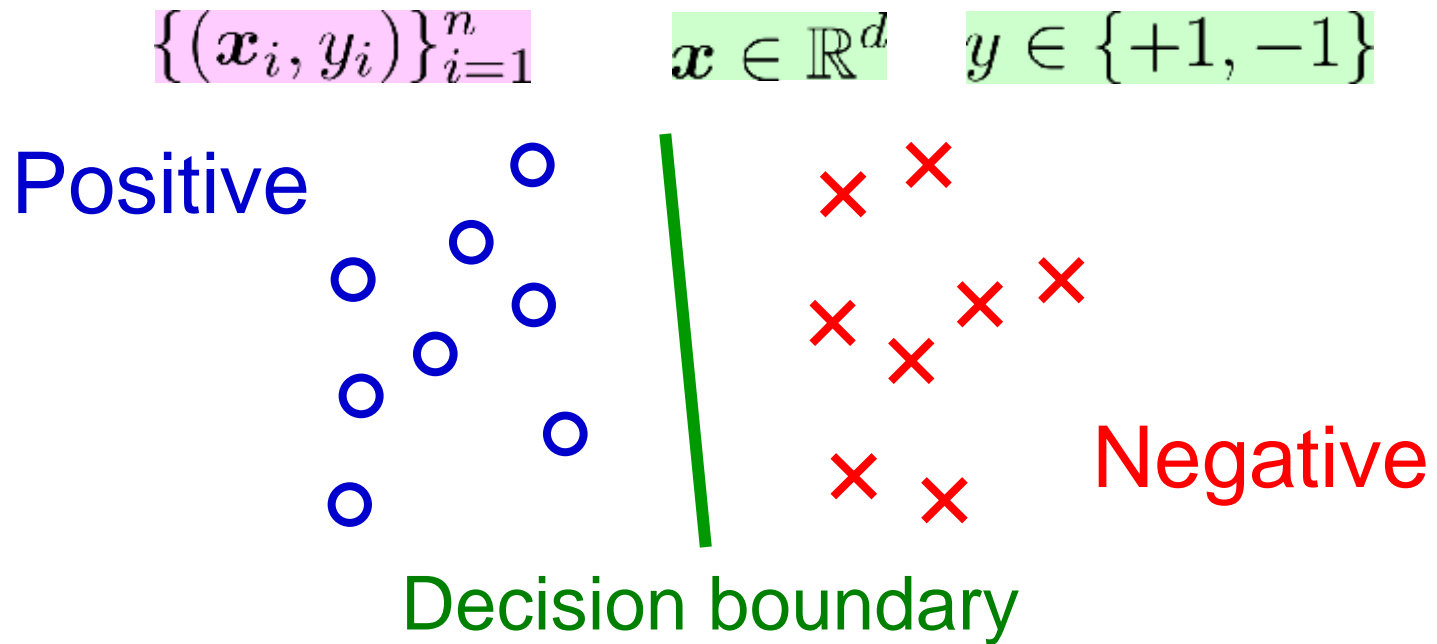
2

- **Machine learning from big data** is successful.
 - Great work on large-scale parallel implementation.
- However, there are various applications where **massive labeled data is not available**.
 - Medicine, manufacturing, disaster, infrastructure...
- In this talk, I will introduce our recent advances in **classification from limited information**.

Supervised Classification

3

- Binary classification from labeled samples:



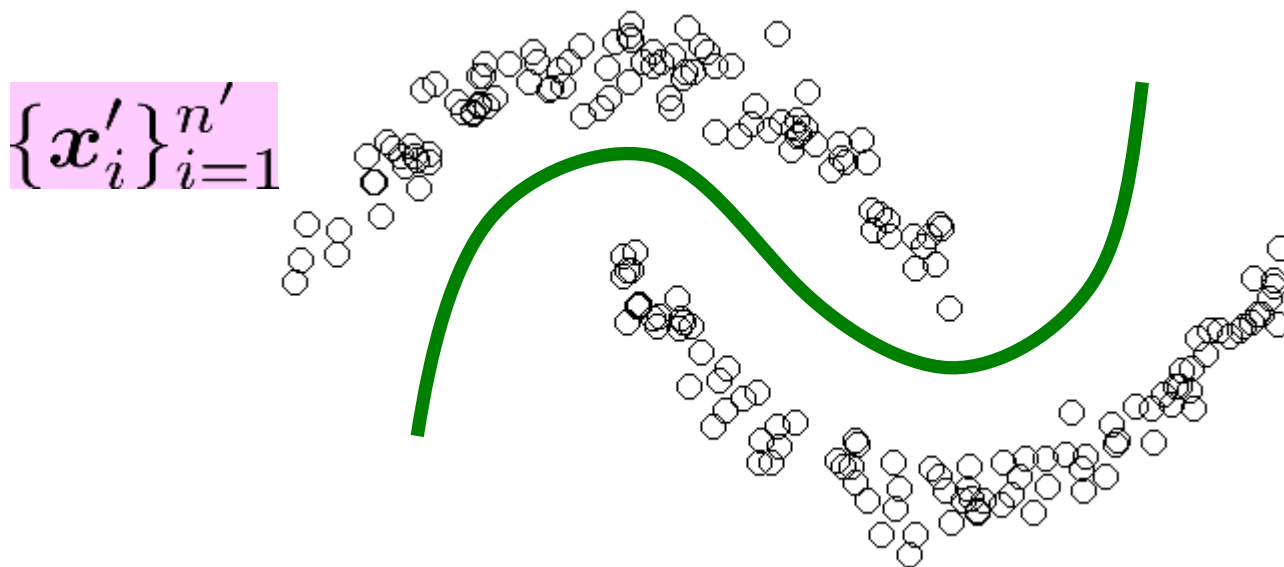
- A large number of labeled samples yield better classification performance.

- Optimal convergence rate: $\mathcal{O}(n^{-1/2})$

Unsupervised Classification

4

- Since collecting labeled samples is costly, let's learn a classifier from **unlabeled data**.

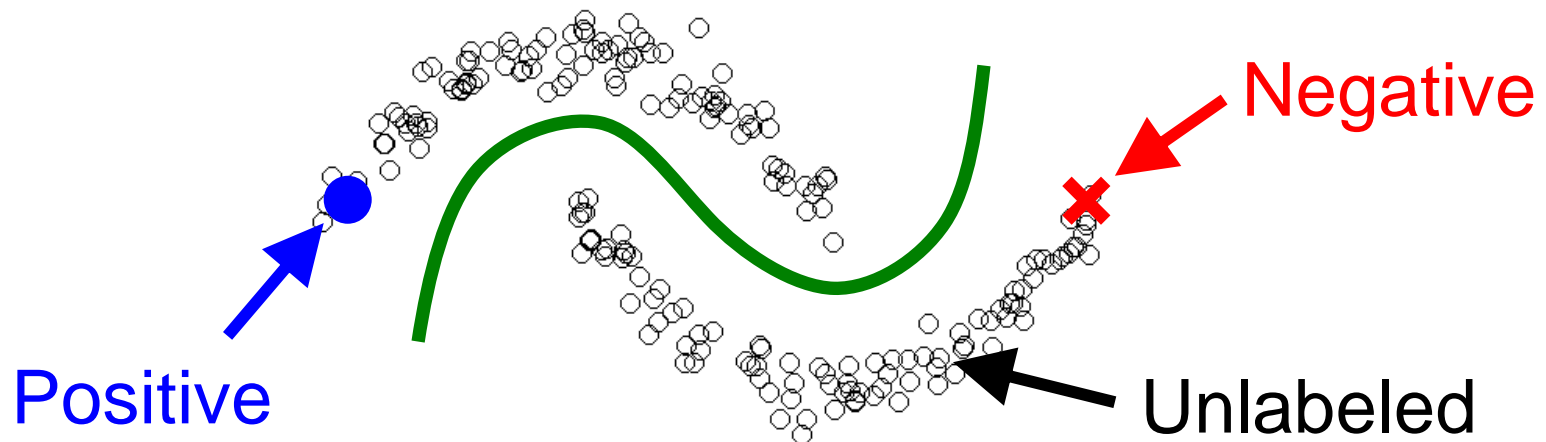


- This is equivalent to **clustering**.
- To justify this, need the assumption that **each cluster corresponds to each class**.
 - This is rarely satisfied in practice.

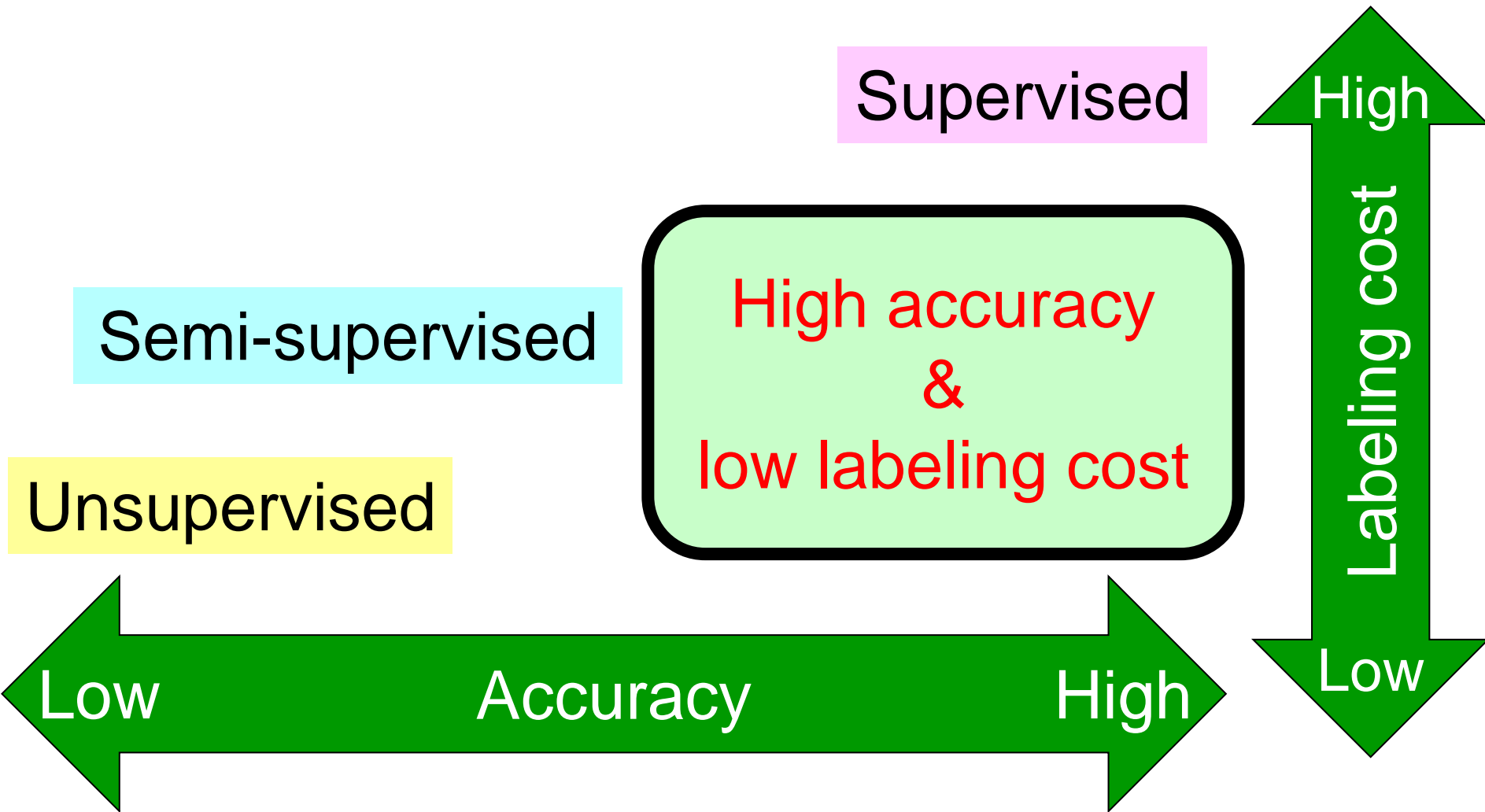
Semi-Supervised Classification ⁵

Zhou, Bousquet, Lal, Weston & Schölkopf (NIPS2003) and many

- Use a large number of **unlabeled** samples and a small number of **labeled** samples:
- Find a decision boundary **along cluster structure** induced by unlabeled samples:
 - Sometimes very useful!
 - But same weakness as unsupervised classification.



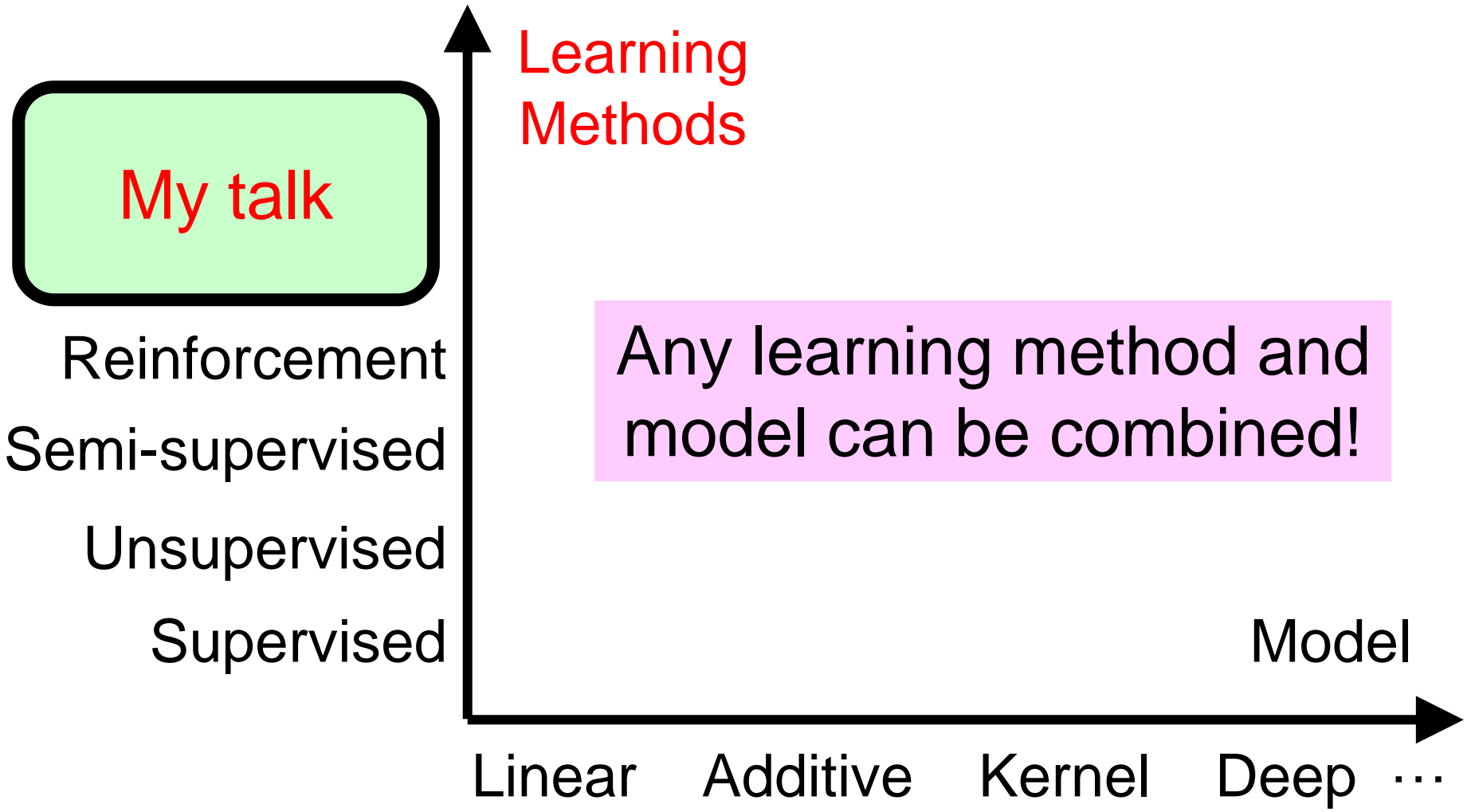
Classification of Classification 6



- Achieving **high classification accuracy** with **low labeling costs** is always a big challenge!

Relation to Deep Learning

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Organization

1. Classification of classification
2. Classification from UU data
3. Classification from PU data
4. Classification from PNU data
5. Classification from complementary labels
6. Introduction RIKEN Center for AIP

UU Classification: Setup

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du Plessis, Niu & Sugiyama (TAAI2013)

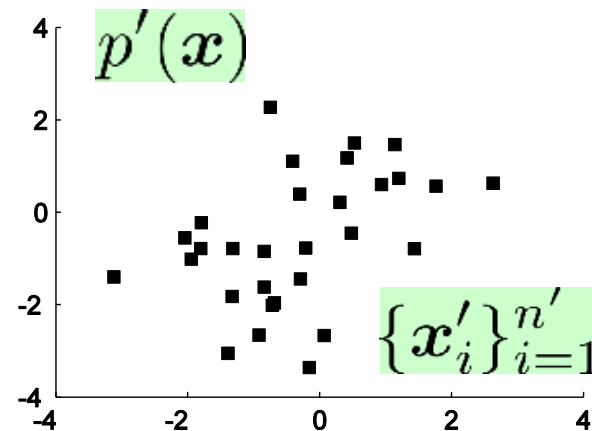
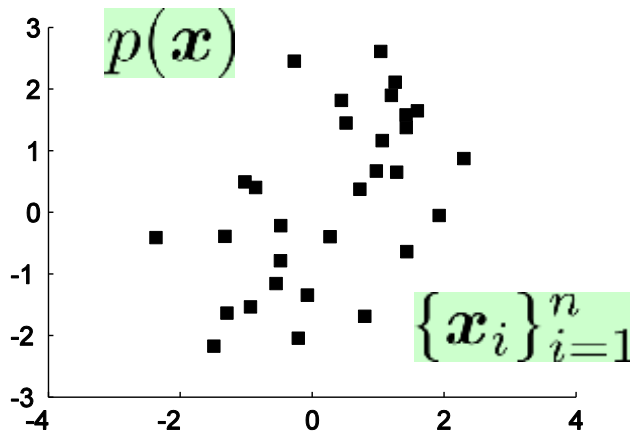
- **Given:** Two sets of unlabeled data

$$\{\mathbf{x}_i\}_{i=1}^n \stackrel{\text{i.i.d.}}{\sim} p(\mathbf{x}) \quad \{\mathbf{x}'_i\}_{i=1}^{n'} \stackrel{\text{i.i.d.}}{\sim} p'(\mathbf{x})$$

- **Assumption:** Only class-priors are different

$$p(y) \neq p'(y) \quad p(\mathbf{x}|y) = p'(\mathbf{x}|y)$$

- **Goal:** Obtain a classifier



Optimal UU Classifier

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du Plessis, Niu & Sugiyama (TAAI2013)

- Sign of the difference of class-posteriors:

$$g(\mathbf{x}) = \text{sign}[p(y = +1|\mathbf{x}) - p(y = -1|\mathbf{x})]$$

- Under **equal** test class-prior $q(y = +1) = 1/2$,

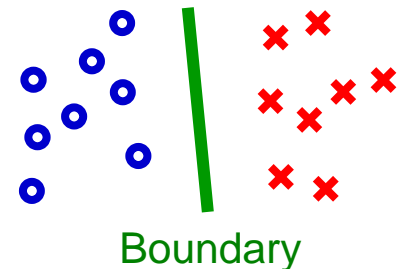
$$g(\mathbf{x}) = C \text{sign}[p(\mathbf{x}) - p'(\mathbf{x})]$$

$$C = \text{sign}[p(y = +1) - p'(y = +1)]$$

- Sign of C is unknown, but just knowing

$$\text{sign}[p(\mathbf{x}) - p'(\mathbf{x})]$$

still allows **optimal separation!**



UU Classifier Training

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$$\text{sign}[p(\mathbf{x}) - p'(\mathbf{x})]$$

■ Difference of kernel density estimators:

- Estimate $p(\mathbf{x}), p'(\mathbf{x})$ from $\{\mathbf{x}_i\}_{i=1}^n, \{\mathbf{x}'_i\}_{i=1}^{n'}$, separately.
- Simple but systematic under-estimation of $p(\mathbf{x}) - p'(\mathbf{x})$.

Anderson, Hall & Titterington (J. Multivariate Analysis 1994)

■ Direct estimation of density-difference:

- Fit model $f(\mathbf{x})$ to $p(\mathbf{x}) - p'(\mathbf{x})$ directly without estimating $p(\mathbf{x}), p'(\mathbf{x})$.
- Linear least-squares formulation yields global analytic solution!

Kim & Scott (IEEE-TPAMI2010)
Sugiyama, Suzuki, Kanamori,
du Plessis, Liu & Takeuchi
(NIPS2012, NeCo2013)

$$\min_f \int \left(f(\mathbf{x}) - \{p(\mathbf{x}) - p'(\mathbf{x})\} \right)^2 d\mathbf{x}$$

■ Direct estimation of sign of density-difference:

du Plessis, Niu & Sugiyama (TAAI2013)

- Most direct approach (following Vapnik's principle!).
- Non-convex optimization is involved (use, e.g., CCCP).

Experiments

Misclassification error rate: average (std)

5% t-test

UU classification

Clustering

Spectral
Ng et al.
(NIPS2001)

Infomax
Sugiyama et al.
(ICML2011)

Dataset	UU classification			Clustering		
	DSDD	LSDD	KDE	KM	SC	SMIC
australian	.244 (.116)	.259 (.088)	.355 (.104)	.265 (.080)	.376 (.065)	.308 (.107)
banana	.338 (.094)	.339 (.100)	.365 (.067)	.433 (.049)	.427 (.069)	.424 (.070)
diabetes	.340 (.075)	.361 (.124)	.345 (.034)	.373 (.063)	.380 (.048)	.371 (.114)
german	.375 (.042)	.380 (.093)	.354 (.057)	.437 (.024)	.445 (.057)	.438 (.041)
heart	.270 (.133)	.247 (.084)	.354 (.052)	.264 (.059)	.315 (.081)	.327 (.089)
image	.331 (.078)	.350 (.067)	.350 (.039)	.384 (.031)	.354 (.049)	.382 (.050)
ionosphere	.291 (.099)	.356 (.066)	.345 (.048)	.330 (.070)	.322 (.058)	.314 (.107)
saheart	.378 (.093)	.353 (.057)	.363 (.066)	.419 (.082)	.395 (.022)	.385 (.040)
thyroid	.227 (.098)	.251 (.087)	.302 (.022)	.326 (.061)	.329 (.047)	.307 (.076)
twonorm	.164 (.188)	.153 (.121)	.352 (.096)	.036 (.053)	.042 (.122)	.049 (.120)

$$n = n' = 40$$

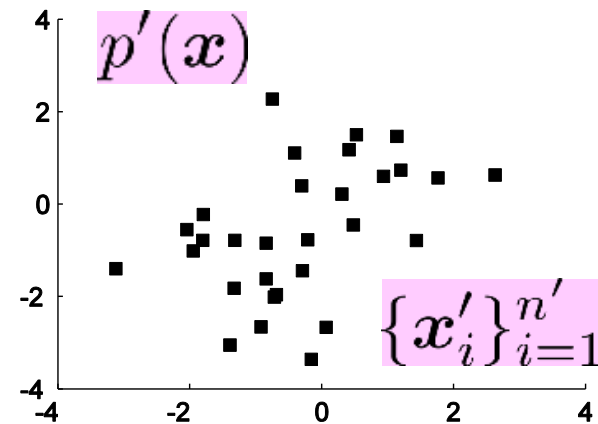
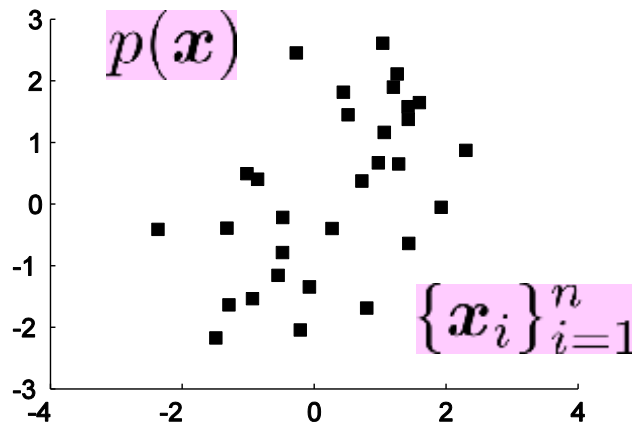
$$p(y = +1) = 0.35$$

$$p'(y = +1) = 0.65$$

- UU classification with direct estimation of (sign of) density difference works well !

UU Classification: Summary

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- Given two unlabeled datasets with different class-priors, we estimate the **sign of difference of class-posteriors**: $\text{sign}[p(\mathbf{x}) - p'(\mathbf{x})]$
- Same convergence rate as fully supervised case can be achieved! $\mathcal{O}(n^{-1/2})$
- Unlike **classification from label proportions**, we do not have to know class priors.

Organization



1. Classification of classification
2. Classification from UU data
3. Classification from PU data
4. Classification from PNU data
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PU Classification: Setup

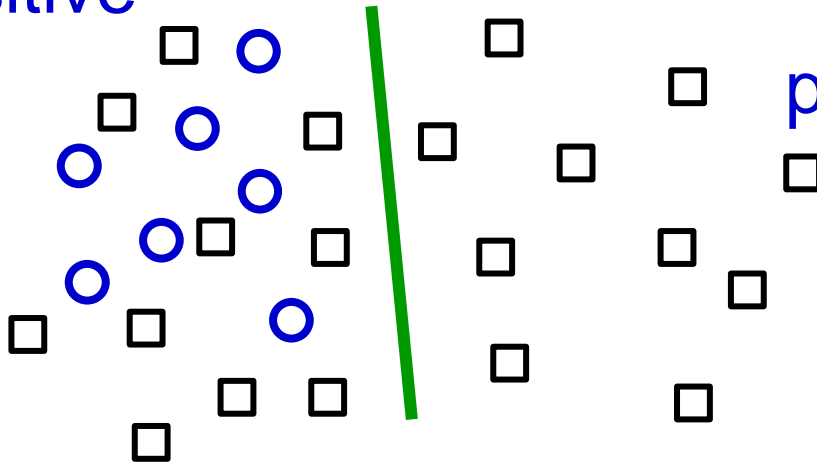
15

- **Given:** Positive and unlabeled samples

$$\{(\mathbf{x}_i, y_i = +1)\}_{i=1}^n \stackrel{\text{i.i.d.}}{\sim} p(\mathbf{x}|y = +1)$$
$$\{\mathbf{x}'_i\}_{i=1}^{n'} \stackrel{\text{i.i.d.}}{\sim} p(\mathbf{x})$$

- **Goal:** Obtain an (ordinary) PN classifier

Positive



Unlabeled (mixture of
positives and negatives)

Examples:

- Click vs. non-click
- Friend vs. non-friend

- Risk of classifier f :

$$R(f) = \mathbb{E}_{p(\mathbf{x}, y)} \left[\ell(y f(\mathbf{x})) \right]$$

\mathbb{E} : Expectation

ℓ : Loss

$$= \underbrace{\pi \mathbb{E}_{p(\mathbf{x}|y=+1)} \left[\ell(f(\mathbf{x})) \right]}_{\text{Risk for P data}} + \underbrace{(1 - \pi) \mathbb{E}_{p(\mathbf{x}|y=-1)} \left[\ell(-f(\mathbf{x})) \right]}_{\text{Risk for N data}}$$

Risk for P data

Risk for N data

$\pi = p(y = +1)$: Class-prior probability
(assumed known; **can be estimated**)

Scott & Blanchard (AISTATS2009)

Blanchard, Lee & Scott (JMLR2010)

du Plessis, Niu & Sugiyama (IEICE2014, MLJ2017)

- Since we do not have N data in the PU setting, the risk cannot be directly estimated.

PU Unbiased Risk Estimation 17

Natarajan, Dhillon, Ravikumar & Tewari (NIPS2013)
du Plessis, Niu & Sugiyama (ICML2015)

$$R(f) = \underbrace{\pi \mathbb{E}_{p(\mathbf{x}|y=+1)} \left[\ell(f(\mathbf{x})) \right]}_{\text{Risk for P data}} + \underbrace{(1 - \pi) \mathbb{E}_{p(\mathbf{x}|y=-1)} \left[\ell(-f(\mathbf{x})) \right]}_{\text{Risk for N data}}$$

- U-density is a mixture of P- and N-densities:

$$p(\mathbf{x}) = \pi p(\mathbf{x}|y = +1) + (1 - \pi) p(\mathbf{x}|y = -1)$$

- Eliminating the N-density yields

$$R(f) = \pi \mathbb{E}_{p(\mathbf{x}|y=+1)} \left[\ell(f(\mathbf{x})) \right] + \mathbb{E}_{p(\mathbf{x}) - \pi p(\mathbf{x}|y=+1)} \left[\ell(-f(\mathbf{x})) \right]$$

- Unbiased risk estimation is possible only from PU data!

Theoretical Analysis

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Niu, du Plessis, Sakai, Ma & Sugiyama (NIPS2016)

■ Estimation error bounds:

$$R(\hat{f}_{\text{PU}}) - R(f^*) \leq C(\delta) (2\pi/\sqrt{n_{\text{P}}} + 1/\sqrt{n_{\text{U}}})$$

$$R(\hat{f}_{\text{PN}}) - R(f^*) \leq C(\delta) (\pi/\sqrt{n_{\text{P}}} + (1 - \pi)/\sqrt{n_{\text{N}}})$$

$$R(f) = \mathbb{E}_{p(\mathbf{x}, y)} \left[\ell(yf(\mathbf{x})) \right]$$

$$f^* = \operatorname{argmin}_f R(f)$$

with probability $1 - \delta$

$n_{\text{P}}, n_{\text{N}}, n_{\text{U}}$: # of positive,
negative and unlabeled samples

- PU (and PN) achieve optimal convergence rate.

■ Comparison: **PU bound is smaller than PN** if

$$\pi/\sqrt{n_{\text{P}}} + 1/\sqrt{n_{\text{U}}} < (1 - \pi)/\sqrt{n_{\text{N}}}$$

- **PU can be better than PN**
provided a large number of PU data!

Further Correction

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Kiryu, Niu, du Plessis & Sugiyama (arXiv2017)

■ PN formulation:

$$R(f) = \underbrace{\pi \mathbb{E}_{p(\mathbf{x}|y=+1)} \left[\ell \left(f(\mathbf{x}) \right) \right]}_{\text{Risk for P data}} + \underbrace{(1 - \pi) \mathbb{E}_{p(\mathbf{x}|y=-1)} \left[\ell \left(-f(\mathbf{x}) \right) \right]}_{\text{Risk for N data}}$$

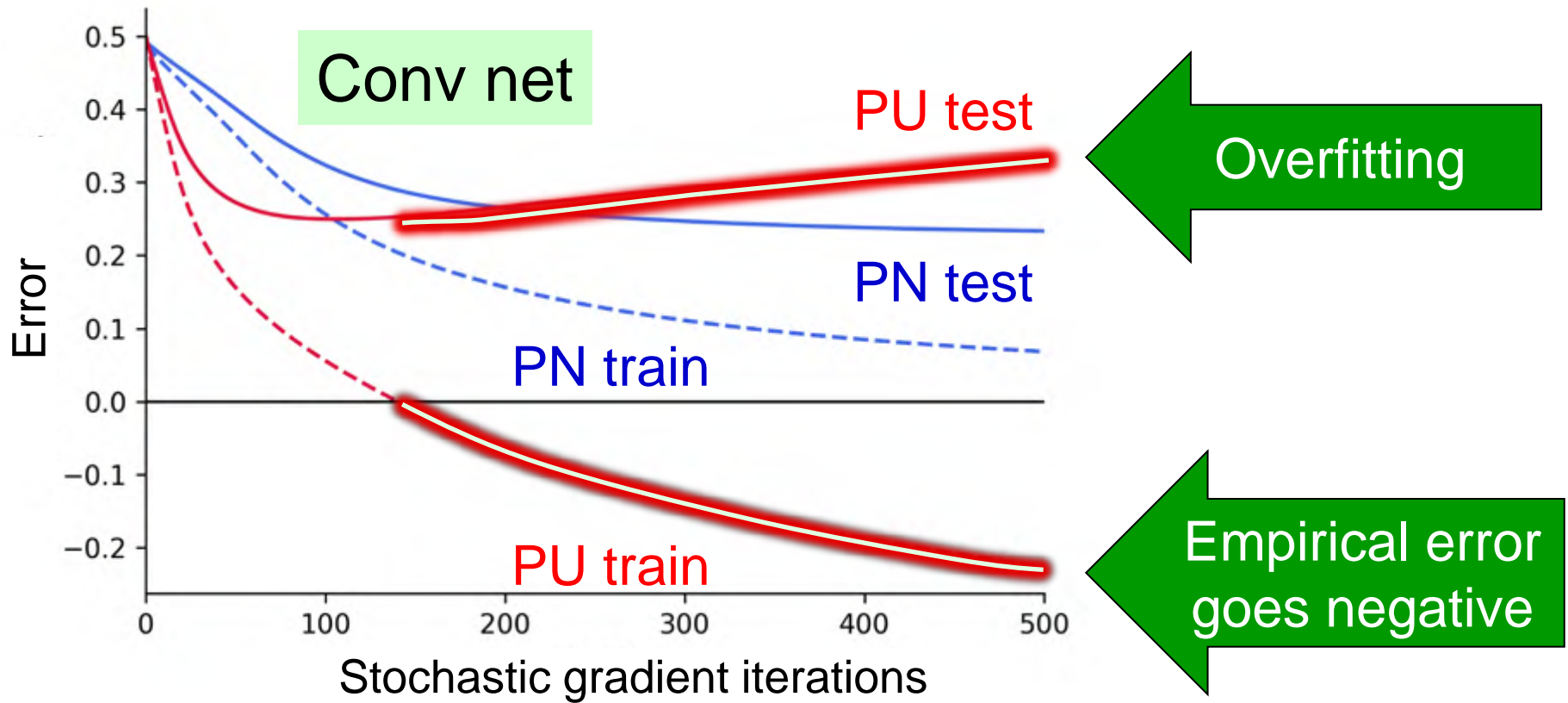
■ PU formulation: $p(\mathbf{x}) = \pi p(\mathbf{x}|y = +1) + (1 - \pi)p(\mathbf{x}|y = -1)$

$$R(f) = \pi \mathbb{E}_{p(\mathbf{x}|y=+1)} \left[\ell \left(f(\mathbf{x}) \right) \right] + \mathbb{E}_{p(\mathbf{x}) - \pi p(\mathbf{x}|y=+1)} \left[\ell \left(-f(\mathbf{x}) \right) \right]$$

■ Risk for N data is non-negative by definition, but **its approximation from PU samples can be negative** due to “difference of approximations”.

- In particular, for flexible models such as **deep nets**.

Non-Negative PU Classification²⁰



- We constrain the sample approximation term **to be non-negative** through back-prop training:

$$\hat{R}(f) = \pi \hat{\mathbb{E}}_{p(\mathbf{x}|y=+1)} [\ell(f(\mathbf{x}))] + \max \left\{ 0, \hat{\mathbb{E}}_{p(\mathbf{x}) - \pi p(\mathbf{x}|y=+1)} [\ell(-f(\mathbf{x}))] \right\}$$

- Now the risk estimator is biased. Is it really good?

$$\widehat{R}(f) = \pi \widehat{\mathbb{E}}_{p(\mathbf{x}|y=+1)} [\ell(f(\mathbf{x}))] + \max \left\{ 0, \widehat{\mathbb{E}}_{p(\mathbf{x}) - \pi p(\mathbf{x}|y=+1)} [\ell(-f(\mathbf{x}))] \right\}$$

- $\widehat{R}(f)$ is still **consistent** and **its bias decreases exponentially**: $\mathcal{O}(\exp(-1/n_P + 1/n_U))$

n_P, n_U : # of positive and unlabeled samples

- In practice, we can ignore the bias of $\widehat{R}(f)$!

- Mean-squared error of $\widehat{R}(f)$ is not more than the original one.

- In practice, $\widehat{R}(f)$ is more reliable!

- Risk of $\operatorname{argmin}_f \widehat{R}(f)$ for linear models converges with **optimal parametric order**: $\mathcal{O}(1/\sqrt{n_P} + 1/\sqrt{n_U})$

- Learned function is optimal.

Experiments

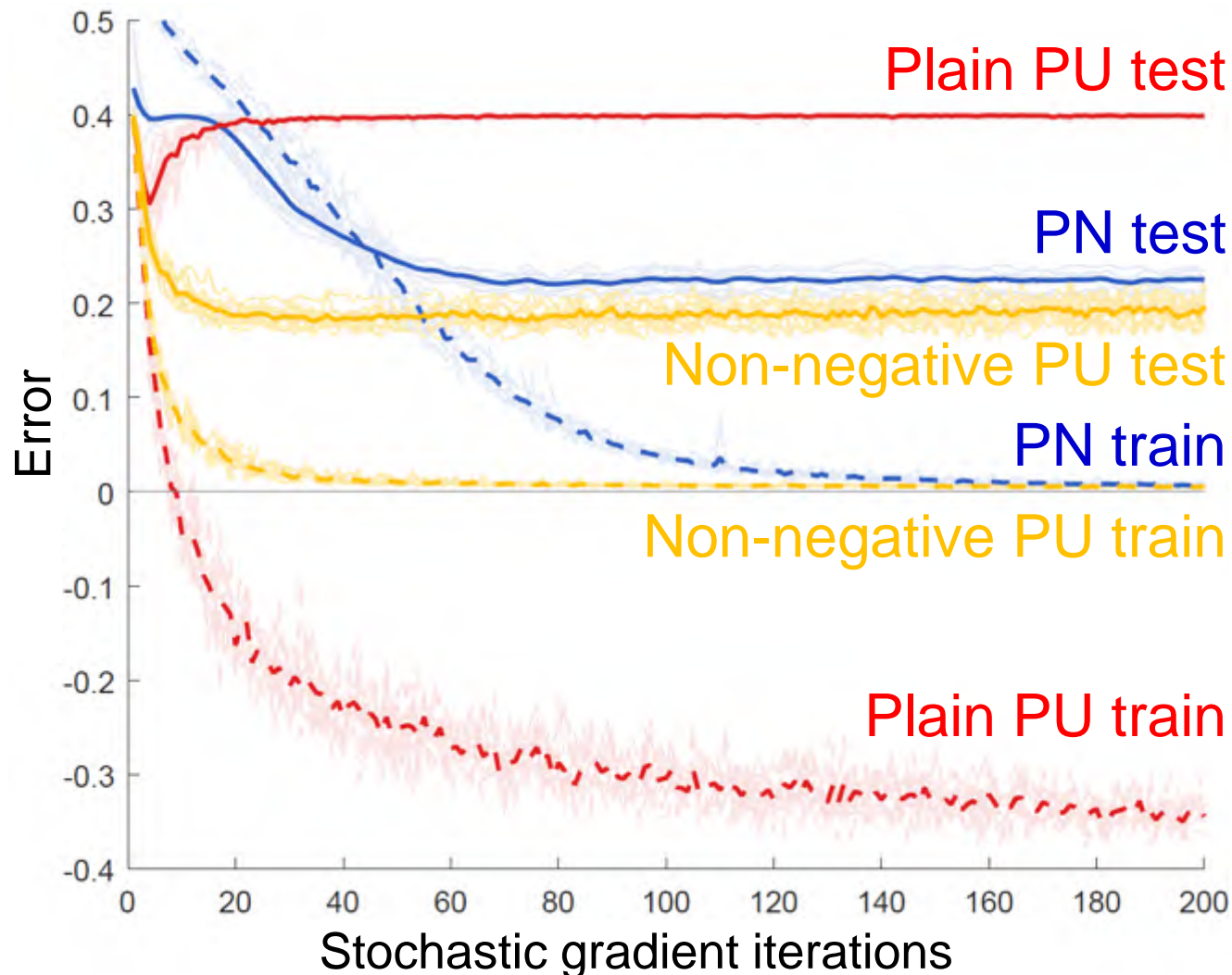
■ With a large number of unlabeled data, non-negative PU can even outperform PN!

- Binary CIFAR-10:
Positive (airplane, automobile, ship, truck)
Negative (bird, cat, deer, dog, frog, horse)
- 13-layer CNN with ReLU

$$n_P = 1000$$

$$n_U = 50000$$

$$\pi = 0.4$$



PU Classification: Summary

- Just separating P and U is biased.
- To be unbiased, use **composite loss**
 $\tilde{l}(m) = l(m) - l(-m)$ for P data.

Natarajan, Dhillon, Ravikumar & Tewari (NIPS2013)

- Optimal convergence rate achieved.**

Niu, du Plessis, Sakai, Ma & Sugiyama (NIPS2016)

- If $l(m) + l(-m) = \text{Const.}$,
the **same loss** for P and U data.

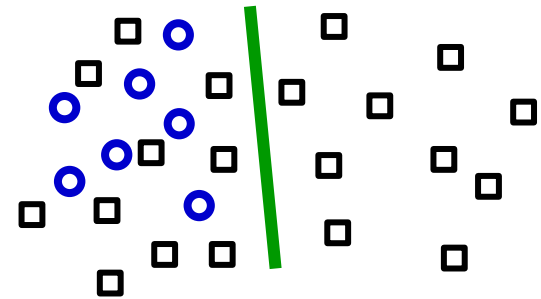
du Plessis, Niu & Sugiyama (NIPS2014)

- If $\tilde{l}(m) = am + b$,
optimization becomes **convex**.

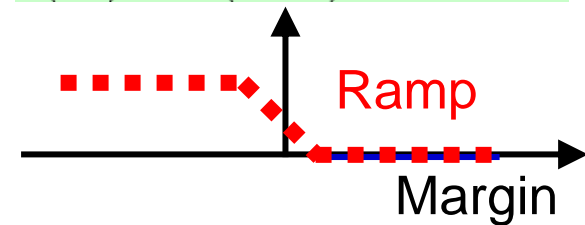
du Plessis, Niu & Sugiyama (ICML2015)

- For deep nets, **roundup**
the **empirical false negative error**.

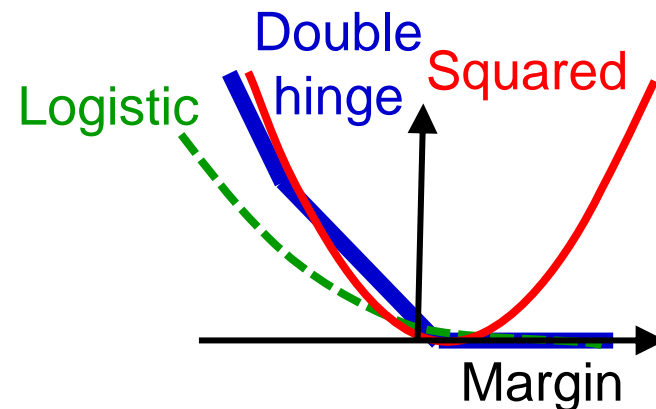
Kiryu, Niu, du Plessis & Sugiyama (arXiv2017)



$$l(m) + l(-m) = \text{Const.}$$



$$\tilde{l}(m) = am + b$$



Organization



1. Classification of classification
2. Classification from UU data
3. Classification from PU data
4. **Classification from PNU data**
5. Classification from complementary labels
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PNU Classification

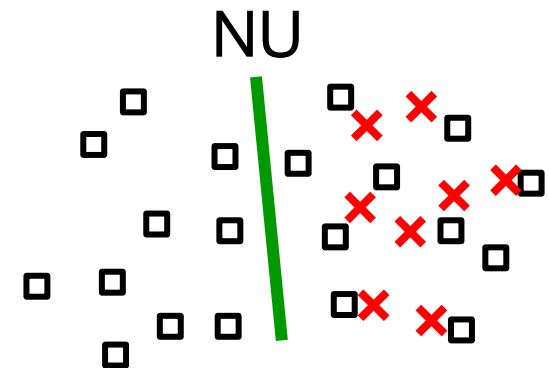
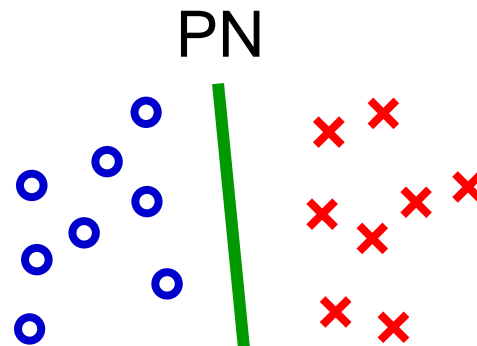
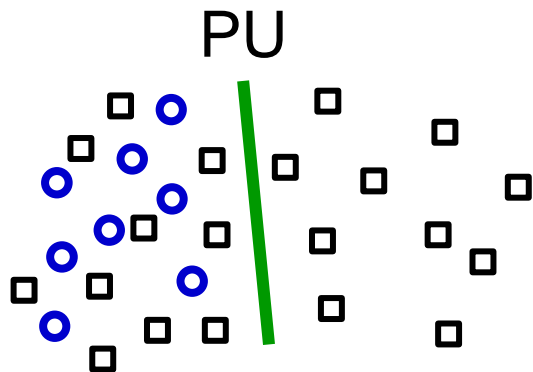
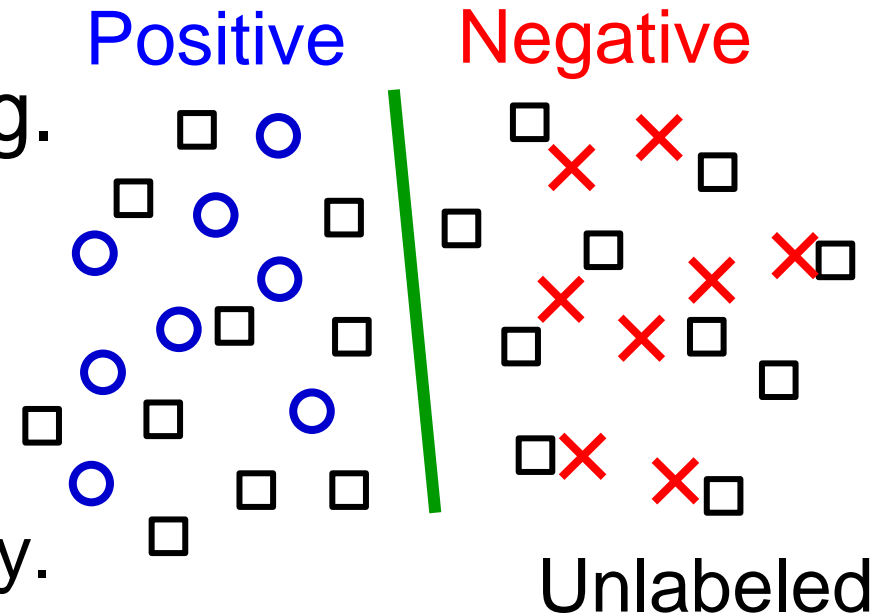
25

Sakai, du Plessis, Niu & Sugiyama (ICML2017)

■ **PNU classification** is semi-supervised learning.

■ Let's decompose this into **PU**, **PN**, and **NU** classification:

- Each can be solved easily.
- Combine two of them!

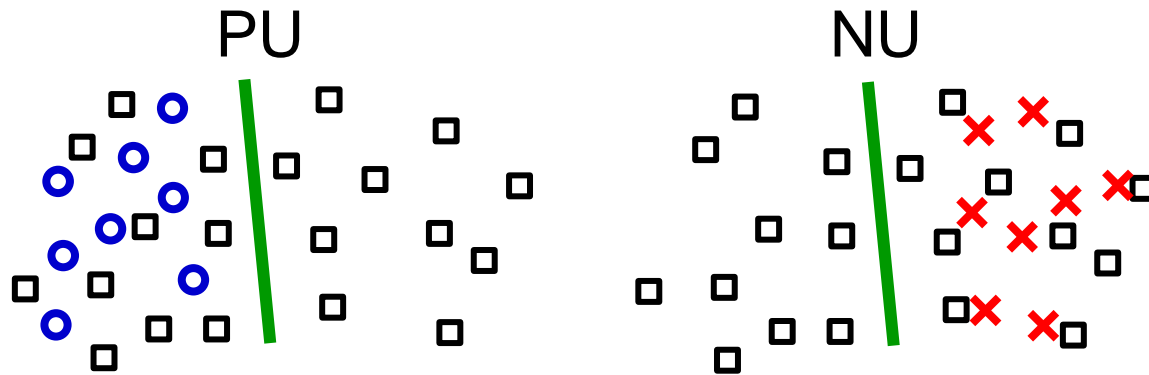


PU+NU Classification

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- Natural choice: Combine PU & NU (symmetric).

$$R_{\text{PU+NU}}(f) = (1 - \gamma)R_{\text{PU}}(f) + \gamma R_{\text{NU}}(f) \quad 0 \leq \gamma \leq 1$$



Niu, du Plessis, Sakai, Ma
& Sugiyama (NIPS2016)

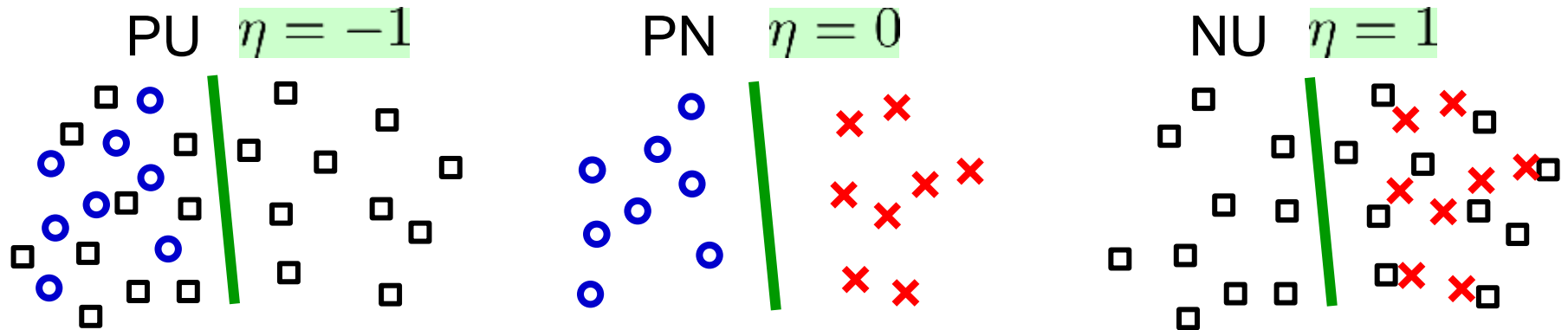
- Theoretical risk analysis:

- When $\text{PU} < \text{NU}$, $\text{PU} < \text{PN} < \text{NU}$ or $\text{PN} < \text{PU} < \text{NU}$.
- When $\text{NU} < \text{PU}$, $\text{NU} < \text{PN} < \text{PU}$ or $\text{PN} < \text{NU} < \text{PU}$.

- PU+NU is not the best possible combination.
- PU+PN & NU+PN are the best combinations.

PN+PU & PN+NU Classification²⁷

- Proposed method: Combine best methods:



$$R_{\text{PNU}}^{\eta}(f) = \begin{cases} R_{\text{PN+PU}}^{\eta}(f) & (\eta \geq 0) \\ R_{\text{PN+NU}}^{-\eta}(f) & (\eta < 0) \end{cases}$$

$$-1 \leq \eta \leq 1$$

- PN+PU classification:

$$R_{\text{PN+PU}}^{\gamma}(f) = (1 - \gamma)R_{\text{PN}}(f) + \gamma R_{\text{PU}}(f)$$

$$0 \leq \gamma \leq 1$$

- PN+NU classification:

$$R_{\text{PN+NU}}^{\gamma}(f) = (1 - \gamma)R_{\text{PN}}(f) + \gamma R_{\text{NU}}(f)$$

$$0 \leq \gamma \leq 1$$

Generalization error bounds:

$$R_{0/1}(f) \leq 2\widehat{R}_{\text{PN+PU}}^\gamma(f) + \mathcal{O}(1/\sqrt{n_{\text{P}}} + 1/\sqrt{n_{\text{N}}} + 1/\sqrt{n_{\text{U}}})$$

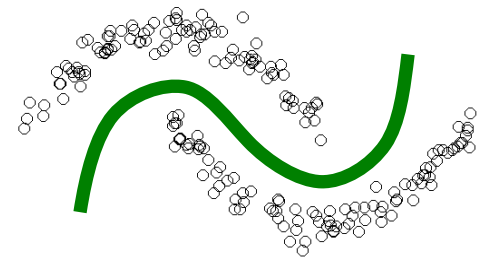
$$R_{0/1}(f) \leq 2\widehat{R}_{\text{PN+NU}}^\gamma(f) + \mathcal{O}(1/\sqrt{n_{\text{P}}} + 1/\sqrt{n_{\text{N}}} + 1/\sqrt{n_{\text{U}}})$$

$$R_{0/1}(f) = \mathbb{E}_{p(\mathbf{x},y)} \left[\ell_{0/1}(yf(\mathbf{x})) \right]$$

\widehat{R} : Empirical version of R

$n_{\text{P}}, n_{\text{N}}, n_{\text{U}}$: # of positive, negative and unlabeled samples

- Unlabeled data always helps without cluster assumptions!



- We use unlabeled data for **loss evaluation**, not for **regularization** (as manifold smoothing).
 - Label information is extracted from unlabeled data!

Experiments

Misclassification error rate: average (std)

5% t-test

(Grandvalet & Bengio, (Belkin et al., (Niu et al., (Li et al.,
NIPS2004) JMLR2006) ICML2013) JMLR2013)

Dataset	n_u	π	$\hat{\pi}$	Proposed	EntReg	LapSVM	SMIR	WellSVM
Arts	1000	0.50	0.49 (0.01)	27.4 (1.3)	26.6 (0.5)	26.1 (0.7)	40.1 (3.9)	27.5 (0.5)
	5000	0.50	0.50 (0.01)	24.8 (0.6)	26.1 (0.5)	26.1 (0.4)	30.1 (1.6)	N/A
	10000	0.50	0.52 (0.01)	25.6 (0.7)	25.4 (0.5)	25.5 (0.6)	N/A	N/A
Deserts	1000	0.73	0.67 (0.01)	13.0 (0.5)	15.3 (0.6)	16.7 (0.8)	17.2 (0.8)	18.2 (0.7)
	5000	0.73	0.67 (0.01)	13.4 (0.4)	13.3 (0.5)	16.6 (0.6)	24.4 (0.6)	N/A
	10000	0.73	0.68 (0.01)	13.3 (0.5)	13.7 (0.6)	16.8 (0.8)	N/A	N/A
Fields	1000	0.65	0.57 (0.01)	22.4 (1.0)	26.2 (1.0)	26.6 (1.3)	28.2 (1.1)	26.6 (0.8)
	5000	0.65	0.57 (0.01)	20.6 (0.5)	22.6 (0.6)	24.7 (0.8)	29.6 (1.2)	N/A
	10000	0.65	0.57 (0.01)	21.6 (0.6)	22.5 (0.6)	25.0 (0.9)	N/A	N/A
Stadiums	1000	0.50	0.50 (0.01)	11.4 (0.4)	11.5 (0.5)	12.5 (0.5)	17.4 (3.6)	11.7 (0.4)
	5000	0.50	0.50 (0.01)	11.0 (0.5)	10.9 (0.3)	11.1 (0.3)	13.4 (0.7)	N/A
	10000	0.50	0.51 (0.00)	10.7 (0.3)	10.9 (0.3)	11.2 (0.2)	N/A	N/A
Platforms	1000	0.27	0.33 (0.01)	21.8 (0.5)	23.9 (0.6)	24.1 (0.5)	30.1 (2.3)	26.2 (0.8)
	5000	0.27	0.34 (0.01)	23.3 (0.8)	24.4 (0.7)	24.9 (0.7)	26.6 (0.3)	N/A
	10000	0.27	0.34 (0.01)	21.4 (0.5)	24.3 (0.6)	24.8 (0.5)	N/A	N/A
Temples	1000	0.55	0.51 (0.01)	43.9 (0.7)	43.9 (0.6)	43.4 (0.6)	50.7 (1.6)	44.3 (0.5)
	5000	0.55	0.54 (0.01)	43.4 (0.9)	43.0 (0.6)	43.1 (1.0)	43.6 (0.7)	N/A
	10000	0.55	0.50 (0.01)	45.2 (0.8)	44.4 (0.8)	44.2 (0.7)	N/A	N/A

■ Proposed PN+PU & PN+NU works well!



Organization

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1. Classification of classification
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6. Introduction RIKEN Center for AIP

Classification from Complementary Labels

Ishida, Niu & Sugiyama (arXiv2017)

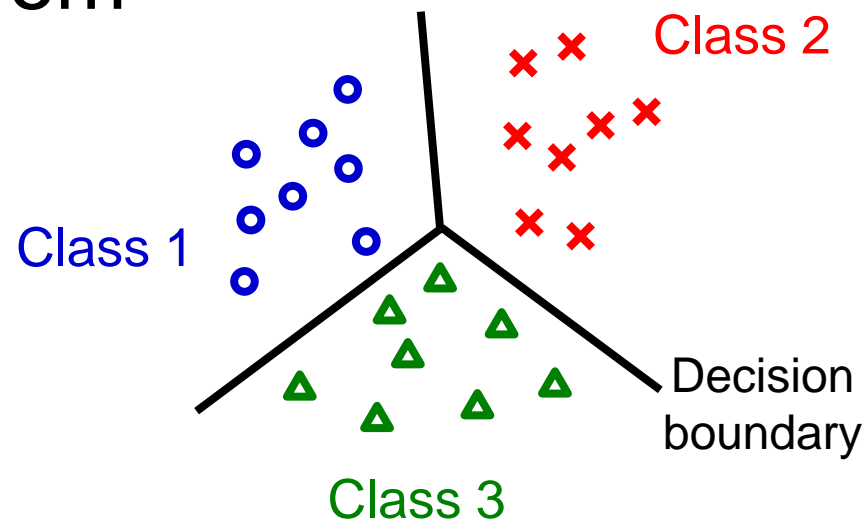
Complementary label: $\bar{y} \in \{1, 2, \dots, c\}$

- Pattern \mathbf{x} does **not** belong to class \bar{y} .
- Choosing a complementary class is **less laborious** than choosing an ordinary class label for large c .

Goal: Learn a classifier from complementary labels.

$$\{(\mathbf{x}_i, \bar{y}_i)\}_{i=1}^n \stackrel{\text{i.i.d.}}{\sim} \bar{p}(\mathbf{x}, \bar{y})$$

$$\bar{p}(\mathbf{x}, \bar{y}) = \frac{1}{c-1} \sum_{y \neq \bar{y}} p(\mathbf{x}, y)$$



Possible Approaches

$$\{(\mathbf{x}_i, \bar{y}_i)\}_{i=1}^n \stackrel{\text{i.i.d.}}{\sim} \bar{p}(\mathbf{x}, \bar{y})$$

■ Approach 1: Classification from partial labels

Cour, Sapp & Taskar (JMLR2011)

- Multiple candidate classes are provided for each \mathbf{x}_i .
- Complementary labels are the extreme case of partial labels given to all $c - 1$ classes other than \bar{y}_i .

■ Approach 2: Multi-label classification

- Each \mathbf{x}_i can belong to multiple classes.
- Negative label for \bar{y}_i and positives for the rest.

■ We want a more direct approach!

Unbiased Risk Estimation with 33 Complimentary Labels

Ishida, Niu & Sugiyama (arXiv2017)

■ c -class classifier: $f(\mathbf{x}) = \operatorname{argmax}_{y \in \{1, \dots, c\}} g_y(\mathbf{x})$

$g_y(\mathbf{x})$: 1-vs-rest classifier for y

■ Classification risk:

$$R(f) = \mathbb{E}_{p(\mathbf{x}, y)} \left[\sum_{y \neq y'} \ell \left(g_y(\mathbf{x}) - g_{y'}(\mathbf{x}) \right) \right]$$

\mathbb{E} : Expectation

■ For **pairwise symmetric loss**, risk is

$$R(f) = \frac{1}{c-1} \mathbb{E}_{\bar{p}(\mathbf{x}, \bar{y})} \left[\sum_{y \neq \bar{y}} \ell \left(g_y(\mathbf{x}) - g_{\bar{y}}(\mathbf{x}) \right) \right] - \text{Const.}$$

$$\ell(m) = 1 / \left(1 + e^m \right)$$

● Unbiased risk estimation is

possible from $\{(\mathbf{x}_i, \bar{y}_i)\}_{i=1}^n \stackrel{\text{i.i.d.}}{\sim} \bar{p}(\mathbf{x}, \bar{y})$!

■ Estimation error:

$$R(f^*) - R(\hat{f}) = \mathcal{O}_p(n^{-1/2})$$

$$R(f) = \mathbb{E}_{p(\mathbf{x}, y)} \left[\mathcal{L}(f(\mathbf{x}), y) \right]$$

$$f^* = \operatorname{argmin}_f \mathbb{E}_{p(\mathbf{x}, y)} \mathcal{L}(f(\mathbf{x}), y)$$

$$\hat{f} = \operatorname{argmin}_f \sum_{i=1}^n \bar{\mathcal{L}}(f(\mathbf{x}_i), \bar{y}_i)$$

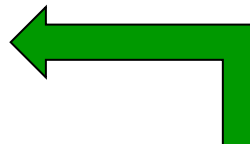
■ Optimal parametric convergence rate!

Experiments

Correct classification rate: average (std)

5% t-test

Dataset	Class	# train	# test	Proposed	Partial-label	Multi-label	Ordinary label
WAVEFORM1	1 ~ 3	1230	406	85.7(0.9)	84.1(1.5)	84.7(1.6)	85.8(0.9)
WAVEFORM2	1 ~ 3	1221	400	84.4(1.3)	83.1(2.7)	81.8(2.3)	86.7(1.8)
SATIMAGE	1 ~ 7	415	211	67.2(7.0)	54.8(6.8)	51.6(6.0)	67.9(4.2)
SHUTTLE	1, 4, 5	2458	809	94.9(9.7)	97.5(0.7)	90.4(11.8)	97.5(0.8)
SEGMENTATION	1 ~ 7	29	299	36.1(6.8)	31.7(5.8)	26.6(5.4)	58.6(4.5)
PENDIGITS	1 ~ 5	719	336	79.4(9.5)	73.2(6.4)	75.9(7.7)	78.8(2.9)
	6 ~ 10	719	335	77.7(3.8)	65.5(6.4)	72.0(8.6)	74.7(4.6)
	even #	719	335	74.0(7.3)	58.5(9.9)	65.7(6.3)	74.8(5.5)
	odd #	719	336	88.5(5.9)	74.6(4.4)	79.1(6.1)	84.0(8.8)
MNIST	1 ~ 5	5842	980	88.4(4.2)	71.5(7.4)	56.6(12.4)	77.9(0.4)
	6 ~ 10	5421	892	83.4(2.6)	67.4(8.1)	50.5(13.7)	77.0(4.5)
	even #	5421	892	85.3(2.2)	70.4(6.7)	61.7(11.1)	76.7(1.4)
	odd #	5842	958	85.0(3.7)	67.3(8.6)	57.3(13.0)	76.5(0.7)
DRIVE	1 ~ 5	3931	1280	87.6(5.9)	72.7(7.0)	64.2(12.6)	79.3(5.1)
	6 ~ 10	3958	1318	84.9(5.7)	73.1(5.8)	69.7(9.3)	81.6(2.9)
	even #	3932	1295	82.4(5.6)	72.9(6.6)	63.2(12.8)	83.5(5.3)
	odd #	3931	1310	76.9(8.0)	60.0(6.9)	51.6(9.3)	65.4(3.3)
LETTER	1 ~ 5	565	171	79.6(5.5)	67.6(6.0)	71.0(9.3)	82.2(4.3)
	6 ~ 10	550	178	73.2(6.3)	63.9(6.1)	61.2(10.6)	75.9(5.6)
	11 ~ 15	556	177	73.3(5.9)	66.6(3.4)	59.0(10.1)	75.4(5.0)
	16 ~ 20	550	184	71.5(5.9)	64.9(5.2)	63.5(7.0)	73.9(5.3)
	21 ~ 25	585	167	76.2(6.0)	68.3(8.1)	63.1(11.2)	77.1(5.1)
VOWEL	1 ~ 5	48	42	35.6(9.0)	37.0(9.3)	31.5(6.7)	54.9(6.7)
	6 ~ 10	48	42	32.6(7.5)	34.1(7.7)	30.0(9.8)	53.0(4.4)
	even #	48	42	36.6(9.0)	39.9(10.5)	33.3(7.8)	62.1(5.6)
	odd #	48	42	28.2(9.0)	28.8(7.2)	23.2(4.8)	54.0(5.5)
USPS	1 ~ 5	652	166	70.1(5.2)	62.8(7.2)	45.8(5.9)	76.2(2.3)
	6 ~ 10	542	147	64.3(4.7)	61.4(5.9)	41.7(5.3)	76.9(5.1)
	even #	556	147	70.6(5.4)	63.7(7.2)	48.4(5.3)	75.7(2.7)
	odd #	542	166	63.1(4.3)	57.8(6.8)	37.8(5.7)	73.6(3.4)



Use only $1/(c-1)$ times less samples since 1 ordinary label corresponds to $(c-1)$ complementary labels

Proposed method works well!

Summary

■ We need continuous effort to achieve high classification accuracy with low labeling!

- UU classification
- PU classification
- PNU classification
- Complementary labels
- And more!

Supervised

Semi-supervised

Unsupervised

High accuracy
&
low labeling costs

High

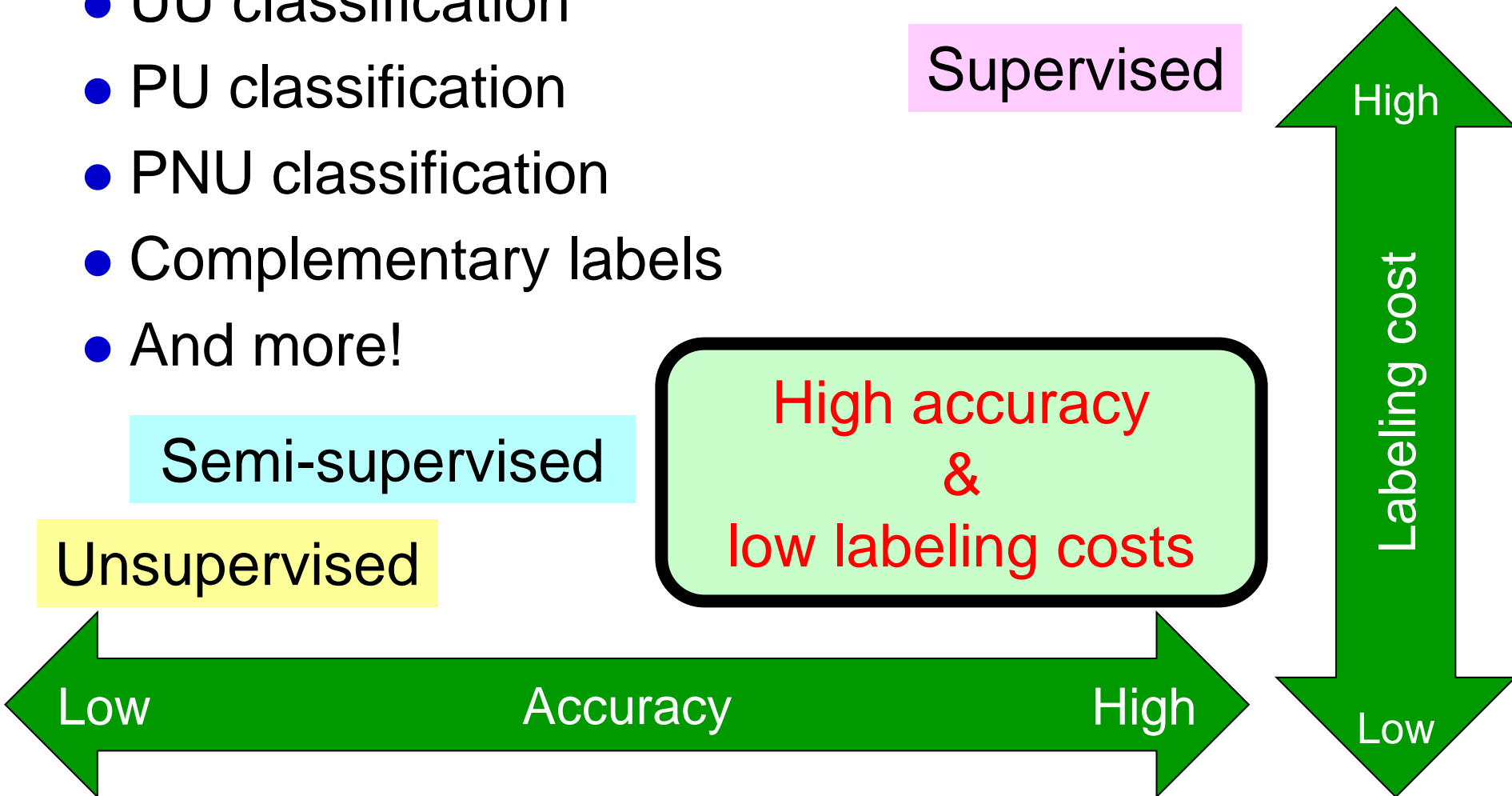
Labeling cost

Low

Low

Accuracy

High



Organization



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- RIKEN founded **Center for Advanced Intelligence Project (AIP)** in 2016.
- Our missions:
 1. **Development of next-generation AI technology** (understand deep learning and go beyond)
 2. **Acceleration of scientific research** (iPS cells, manufacturing, materials...)
 3. **Contribution to solving socially critical problems** (healthcare for super-aged society, disaster resilience, infrastructure management...)
 4. **Study of ethical, legal and social issues of AI.**
 5. **Human resource development** (academia & industry)

Organization of AIP Center

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2017 June 1st

Over 200
researchers!

Various application domains
(companies, universities, research institutes, etc.)

Goal-Oriented Technology Research Group:
Abstract complex real-world problems into solvable forms
(22 teams)

Generic Technology Research Group:
Develop fundamental theory and algorithms
for abstracted problems
(18 teams)

Artificial Intelligence in Society Research Group:
Analyze the influence of AI spreading in society
(8 teams)

NEC/
Fujitsu/
Toshiba
Collaboration
Centers

International Partners

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■ China

- Peking University
- Nanjing University
- Shanghai University
- Hong Kong University of Science and Technology

■ Korea

- KAIST
- Postech
- Artificial Intelligence Research Institute

■ Singapore

- National University of Singapore

■ US

- Toyota Technological Institute at Chicago
- University of Pennsylvania

■ Germany

- Berlin Big Data Center
- Technische Universitaet Darmstadt

■ UK

- Edinburgh Center for Robotics

■ Finland

- Aalto University

More
coming
soon!



With Dr. Bill Dally (NVIDIA SVP) (Feb. 27, 2017)

<https://blogs.nvidia.co.jp/2017/03/06/fujitsu-ai-supercomputer/>

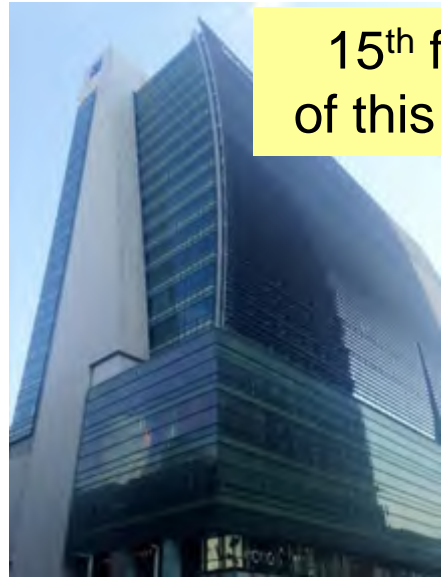


- **24 x NVIDIA DGX-1** (half-precision 4PFLOPS)
 - The largest customer installation of DGX-1 systems in March 2017.
- **Ranked 4th in the Green500 List** (June 2017)
 - 10.602GFLOPS/W

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